

October 1996 Revised December 2003

# 74LVX112

# Low Voltage Dual J-K Flip-Flops with Preset and Clear

### **General Description**

The LVX112 is a dual J-K Flip-Flop where each flip-flop has independent inputs (J, K, PRESET, CLEAR, and CLOCK) and outputs (Q,  $\overline{\mathbb{Q}}$ ). These devices are edge sensitive and change states synchronously on the negative going transition of the clock pulse. Triggering occurs at a voltage level of the clock and is not directly related to the transition time. Clear and Preset are independent of the clock and are accomplished by a low logic level on the corresponding input. The J and K inputs can change when the clock is in

either state without affecting the flip-flop, provided that they are in the desired state during the recommended setup and hold times relative to the falling edge of the clock.

The inputs tolerate voltages up to 7V allowing the interface of 5V systems to 3V systems.

#### **Features**

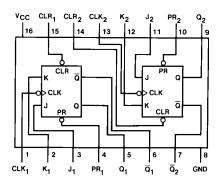
- Input voltage level translation from 5V-3V
- Ideal for low power/low noise 3.3V applications

#### **Ordering Code:**

Order Number	Package Number	Package Description
74LVX112M	M16A	16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow
74LVX112SJ	M16D	16-Lead Small Outline Package (SOP), EIAJ TYPE II, 5.3mm Wide
74LVX112MTC	MTC16	16-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide

Devices also available in Tape and Reel. Specify by appending suffix letter "X" to the ordering code.

### **Connection Diagram**



#### **Pin Descriptions**

Pin Names	Description						
J <sub>1</sub> , J <sub>2</sub> , K <sub>1</sub> , K <sub>2</sub>	Data Inputs						
CLK <sub>1</sub> , CLK <sub>2</sub>	Clock Pulse Inputs (Active Falling edge)						
CLR <sub>1</sub> , CLR <sub>2</sub>	Direct Clear Inputs (Active LOW)						
PR <sub>1</sub> , PR <sub>2</sub>	Direct Preset Inputs (Active LOW)						
$Q_1, Q_2, \overline{Q}_1, \overline{Q}_2$							

# **Truth Table**

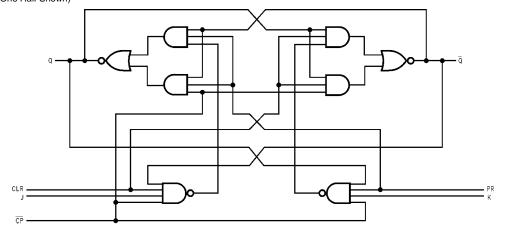
	Ir	Outputs				
PR	CLR	CP	J K		Q	Ø
L	Н	Χ	Х	Х	Н	L
Н	L	Χ	Χ	Χ	L	Н
L	L	Χ	Χ	Χ	Н	Н
Н	Н	$\sim$	h	h	$\overline{Q}_0$	$Q_0$
Н	Н	$\sim$	1	h	L	Н
Н	Н	$\sim$	h	1	Н	L
Н	Н	~	1	1	$Q_0$	$\overline{Q}_0$

- H (h) = HIGH Voltage Level L (l) = LOW Voltage Level X = Immaterial  $\nearrow$  = HIGH-to-LOW Clock Transition Q<sub>0</sub> ( $\overline{Q}_0$ ) = Before HIGH-to-LOW Transition of Clock

Lower case letters indicate the state of the referenced input or output one setup time prior to the HIGH-to-LOW clock transition.

# **Logic Diagram**

(One Half Shown)



# **Absolute Maximum Ratings**(Note 1)

-0.5V to +7.0V Supply Voltage (V<sub>CC</sub>)

DC Input Diode Current (I<sub>IK</sub>)

 $V_1 = -0.5V$ -20 mA DC Input Voltage (V<sub>I</sub>) -0.5V to 7V

DC Output Diode Current (I<sub>OK</sub>)

 $V_0 = -0.5V$ -20 mA  $V_O = V_{CC} + 0.5V$ +20 mA

DC Output Voltage (V<sub>O</sub>) -0.5V to  $V_{CC} + 0.5V$ 

DC Output Source

or Sink Current (I<sub>O</sub>) ±25 mA

DC V<sub>CC</sub> or Ground Current

±50 mA (I<sub>CC</sub> or I<sub>GND</sub>)

-65°C to +150°C Storage Temperature (T<sub>STG</sub>) Power Dissipation 180 mW

## **Recommended Operating** Conditions (Note 2)

2.0V to 3.6V Supply Voltage (V<sub>CC</sub>)

0V to 5.5V Input Voltage (V<sub>I</sub>) Output Voltage (V<sub>O</sub>)  $\rm OV$  to  $\rm V_{CC}$  $-40^{\circ}\text{C}$  to  $+85^{\circ}\text{C}$ Operating Temperature (T<sub>A</sub>)

Input Rise and Fall Time ( $\Delta t/\Delta V$ ) 0 ns/V to 100 ns/V

Note 1: The "Absolute Maximum Ratings" are those values beyond which the safety of the device cannot be guaranteed. The device should not be operated at these limits. The parametric values defined in the Electrical Characteristics tables are not guaranteed at the absolute maximum ratings. The "Recommended Operating Conditions" table will define the conditions

Note 2: Unused inputs must be held HIGH or LOW. They may not float.

for actual device operation.

#### **DC Electrical Characteristics**

Symbol	Parameter	v <sub>cc</sub>	T <sub>A</sub> = +25°C			$T_A = -40^{\circ}C$ to $+85^{\circ}C$		Units	Conditions	
			Min	Тур	Max	Min	Max	Onits	Condit	
V <sub>IH</sub>	HIGH Level	2.0	1.5			1.5				
	Input Voltage	3.0	2.0			2.0		V		
		3.6	2.4			2.4				
V <sub>IL</sub>	LOW Level	2.0			0.5		0.5			
	Input Voltage	3.0			0.8		0.8	V		
		3.6			0.8		0.8			
V <sub>OH</sub>	HIGH Level	2.0	1.9	2.0		1.9			$V_{IN} = V_{IL}$ or $V_{IH}$	$I_{OH} = -50 \mu A$
	Output Voltage	3.0	2.9	3.0		2.9		V		$I_{OH} = -50 \mu A$
		3.0	2.58			2.48				$I_{OH} = -4 \text{ mA}$
V <sub>OL</sub>	Low Level	2.0		0.0	0.1		0.1		$V_{IN} = V_{IL}$ or $V_{IH}$	$I_{OL} = 50  \mu A$
	Output Voltage	3.0		0.0	0.1		0.1	V		$I_{OL} = 50  \mu A$
		3.0			0.36		0.44			$I_{OL} = 4 \text{ mA}$
I <sub>IN</sub>	Input Leakage Current	3.6			±0.1		±1.0	μΑ	$V_{IN} = 5.5V$ or GN	İD
I <sub>CC</sub>	Quiescent Supply Current	3.6			2.0		20.0	μΑ	$V_{IN} = V_{CC}$ or GND	

# **AC Electrical Characteristics**

Symbol	Parameter	V <sub>CC</sub>	$T_A = +25^{\circ}C$			$T_A = -40^{\circ}C \text{ to } +85^{\circ}C$		Units	C <sub>L</sub> (pF)
Cymbol		(V)	Min	Тур	Max	Min	Max	Ullits	OL (p. )
t <sub>PLH</sub>	Propagation Delay	2.7		7.5	12.0	1.0	14.2		15
t <sub>PHL</sub>	$CP_n$ to $Q_n$ or $\overline{Q}_n$			11.0	16.7	1.0	19.0	ns	50
		$3.3 \pm 0.3$		8.5	11.0	1.0	13.4	115	15
				10.0	15.0	1.0	16.5		50
t <sub>PLH</sub>	Propagation Delay	2.7		7.0	11.5	1.0	12.3		15
t <sub>PHL</sub>	PR or CLR to $Q_n$ or $\overline{Q}_n$			10.1	14.3	1.0	16.5	ns	50
		$3.3 \pm 0.3$		6.7	10.2	1.0	11.7	ns	15
				9.7	13.5	1.0	15.0		50
t <sub>W</sub>	Pulse Width	2.7	5.0			5.0			
	(CP or CLR or PR)	$3.3 \pm 0.3$	5.0			5.0		ns	
t <sub>S</sub>	Setup Time	2.7	5.5			5.5			
	(J <sub>n</sub> or K <sub>n</sub> to CP <sub>n</sub> )	$3.3 \pm 0.3$	5.0			5.0		ns	
t <sub>H</sub>	Hold Time	2.7	1.0			1.0			
	(J <sub>n</sub> or K <sub>n</sub> to CP <sub>n</sub> )	$3.3 \pm 0.3$	1.0			1.0		ns	
t <sub>REC</sub>	Recovery Time	2.7	6.5	.5 6.5			ns		
	(CLR or PR to CP)	$3.3 \pm 0.3$	6.0			6.0		115	
f <sub>MAX</sub>	Maximum Clock	2.7	90	140		85			15
	Frequency		85	115		70		MHz	50
		$3.3 \pm 0.3$	110	150		100		IVITIZ	15
			90	120		80			50
t <sub>OSLH</sub> ,	Output to Output Skew	2.7			1.5		1.5	no	50
toshl	(Note 3)	3.3			1.5		1.5	ns	

Note 3: Parameter guaranteed by design.  $t_{OSLH} = |t_{PLHm} - t_{PLHn}|, t_{OSLH} = |t_{PHLm} - t_{PHLn}|$ 

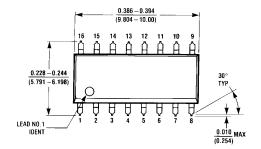
## Capacitance

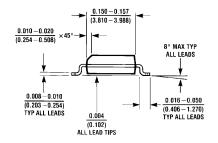
Symbol	Parameter		$T_A = +25^{\circ}C$		T <sub>A</sub> = -40°0	Units	
	T di diffetei	Min	Тур	Max	Min	Max	- Omio
C <sub>IN</sub>	Input Capacitance		4	10		10	pF
C <sub>PD</sub>	Power Dissipation		18				pF
	Capacitance (Note 4)						

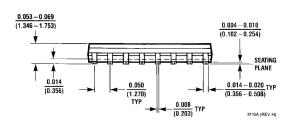
Note 4: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

 $\text{Average operating current can be obtained by the equation: } \\ \text{$I_{CC(opr.)}$} = \frac{C_{PD} \times V_{CC} \times f_{IN} + I_{CC}}{2 \text{ (per F/F)}}$ 

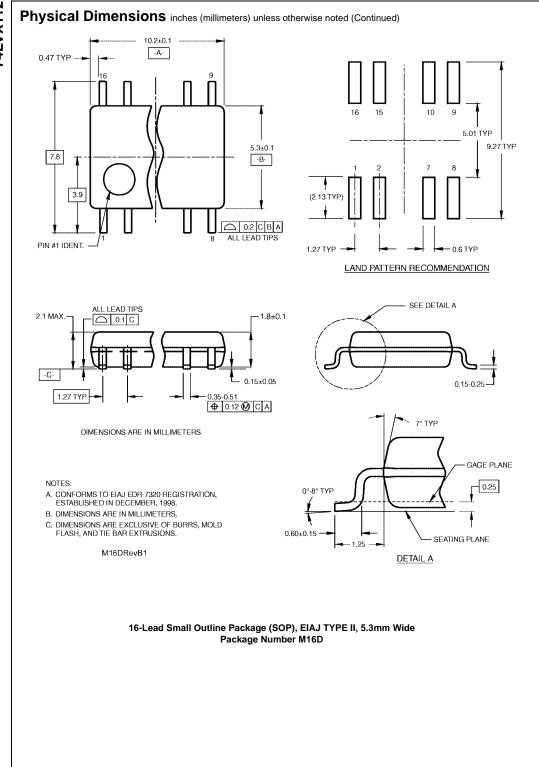
# Physical Dimensions inches (millimeters) unless otherwise noted

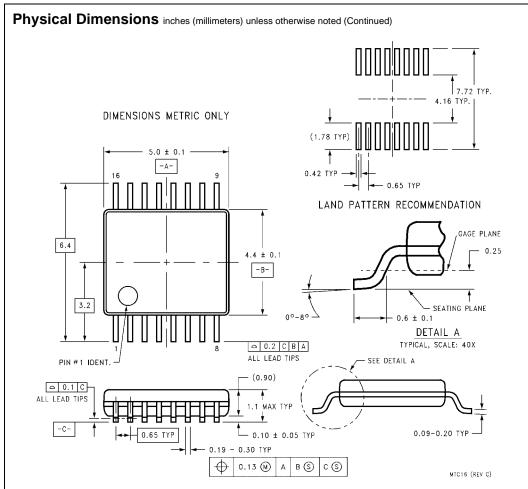






16-Lead Small Outline Integrated Circuit (SOIC), JEDEC MS-012, 0.150" Narrow Package Number M16A





16-Lead Thin Shrink Small Outline Package (TSSOP), JEDEC MO-153, 4.4mm Wide Package Number MTC16

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